onsemi

SyncFET[™] – N-Channel, POWERTRENCH[®]

30 V, 21 A, 4.4 m Ω

FDMC0310AS, FDMC0310AS-F127

General Description

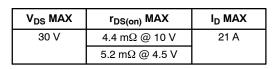
The FDMC0310AS has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance. This device has the added benefit of an efficient monolithic schottky body diode.

Features

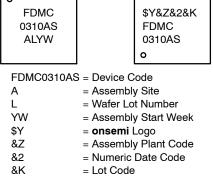
- Max $r_{DS(on)} = 4.4 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 19 \text{ A}$
- Max $r_{DS(on)} = 5.2 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 17.5 \text{ A}$
- Advanced Package and Silicon Combination for Low r_{DS(on)} and High Efficiency
- SyncFET Schottky Body Diode
- MSL1 Robust Package Design
- 100% UIL Tested
- These Devices are Pb-Free and are RoHS Compliant

Applications

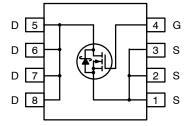
- Synchronous Rectifier for DC/DC Converters
- Notebook Vcore/GPU Low Side Switch
- Networking Point of Load Low Side Switch
- Telecom Secondary Side Rectification











ORDERING INFORMATION

See detailed ordering and shipping information on page 7 of this data sheet.

MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

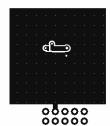
Symbol	Para	Ratings	Unit	
V _{DS}	Drain to Source Voltage		30	V
V _{DSt}	Drain to Source Transient Voltage (t _{Transient} < 100 ns)		33	V
V_{GS}	Gate to Source Voltage (Note 1)		±20	V
I _D	Drain Current	Continuous, T _C = 25°C	21	А
		Continuous, T _A = 25°C (Note 3a)	19	А
		Pulsed	100	А
E _{AS}	Single Pulse Avalanche Energy (Note 2)		66	mJ
PD	Power Dissipation	$T_{C} = 25^{\circ}C$	36	W
		T _A = 25°C (Note 3a)	2.4	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		–55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied. 2. E_{AS} of 66 mJ is based on starting $T_J = 25^{\circ}$ C, L = 0.3 mH, $I_{AS} = 21$ A, $V_{DD} = 27$ V, $V_{GS} = 10$ V. 100% tested at L= 3 mH, $I_{AS} = 10.2$ A.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.4	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 3a)	53	

3. R_{0JA} is determined with the device mounted on a 1 in2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 53°C/W when mounted on a 1 in² pad of 2 oz copper.



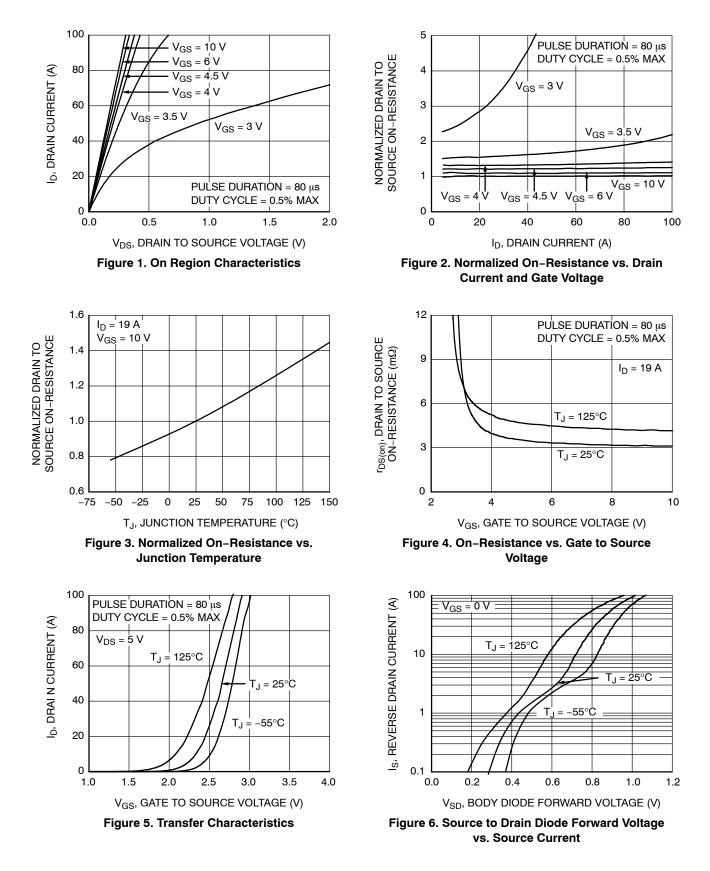
b. $125^{\circ}C/W$ when mounted on a minimum pad of 2 oz copper.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHAR	ACTERISTICS					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 1 mA, V _{GS} = 0 V	30	-	-	V
$\frac{\Delta \text{BV}_{\text{DSS}}}{\Delta \text{T}_{\text{J}}}$	Breakdown Voltage Temperature Coefficient	I_D = 10 mA, referenced to 25°C	-	26	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	500	μΑ
I _{GSS}	Gate to Source Leakage Current, Forward	V_{GS} = 20 V, V_{DS} = 0 V	-	-	100	nA
ON CHARA	CTERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	1.2	1.6	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 10 mA, referenced to 25°C	-	-5	-	mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 19 A	-	3.8	4.4	mΩ
		V _{GS} = 4.5 V, I _D = 17.5 A	-	4.5	5.2	
		V_{GS} = 10 V, I _D = 19 A, T _J = 125°C	-	4.5	5.8	
9 FS	Forward Transconductance	V _{DS} = 5 V, I _D = 19 A	-	106	_	S
DYNAMIC (CHARACTERISTICS					
C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz	-	2380	3165	pF
Coss	Output Capacitance		-	885	1175	pF
C _{rss}	Reverse Transfer Capacitance		-	100	150	pF
Rg	Gate Resistance		0.1	0.7	2.5	Ω
SWITCHING	G CHARACTERISTICS		•			
t _{d(on)}	Turn-On Delay Time	V _{DD} = 15 V, I _D = 19 A	-	11	20	ns
t _r	Rise Time	$V_{GS} = 10 \text{ V}, \overline{R}_{GEN} = 6 \Omega$	-	5	10	ns
t _{d(off)}	Turn-Off Delay Time		-	30	48	ns
t _f	Fall Time		-	4	10	ns
Qg	Total Gate Charge		_	37	52	nC
		V_{GS} = 0 V to 4.5 V V_{DD} = 15 V, I _D = 19 A	-	18	25	nC
Q _{gs}	Gate to Source Charge	V _{DD} = 15 V, I _D = 19 A	-	6	-	nC
Q _{gd}	Gate to Drain "Miller" Charge		-	6	-	nC
DRAIN-SO	URCE DIODE CHARACTERISTICS					
V_{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2 A (Note 4)	-	0.6	0.8	V
		V _{GS} = 0 V, I _S = 19 A (Note 4)	-	0.8	1.2	V
t _{rr}	Reverse Recovery Time	I _F = 19 A, di/dt = 300 A/μs	-	29	47	ns
Q _{rr}	Reverse Recovery Charge		_	33	53	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: Pulse Width < 300 μs, Duty Cycle < 2.0%

TYPICAL CHARACTERISTICS

(T_J = 25°C unless otherwise noted)



TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ (continued)

Ciss

Coss

C_{rss}

30

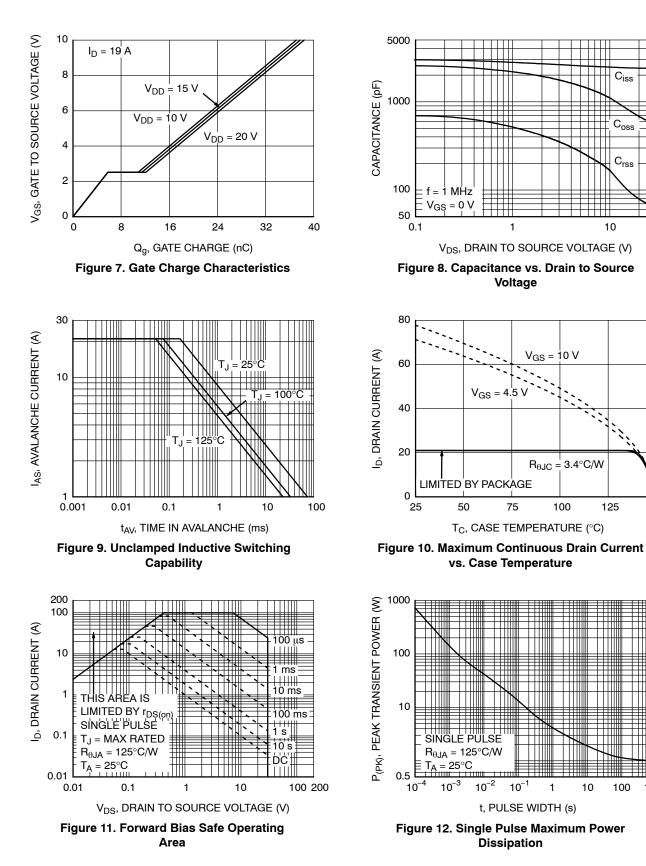
10

125

150

1000

100



TYPICAL CHARACTERISTICS

(T_J = 25°C unless otherwise noted) (continued)

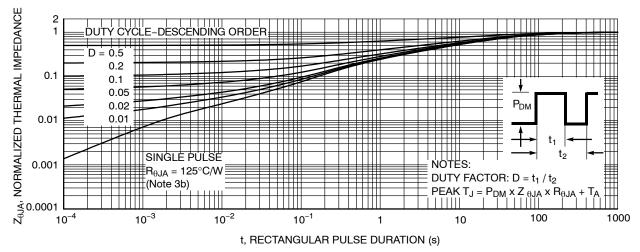


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

TYPICAL CHARACTERISTICS (continued)

SyncFET Schottky Body Diode Characteristics

onsemi SyncFET process embeds a Schottky diode in parallel with POWERTRENCH MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverse recovery characteristic of the FDMC0310AS.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

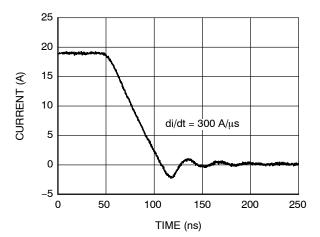


Figure 14. SyncFET Body Diode Reverse Recovery Characteristics

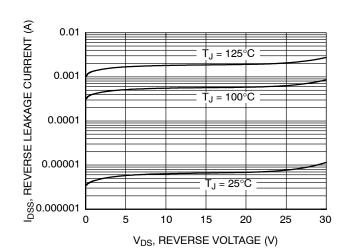


Figure 15. SyncFET Body Diode Reverse Leakage vs. Drain–Source Voltage

PACKAGE MARKING AND ORDERING INFORMATION

Device	Device Marking	Package Type	Reel Size	Tape Width	Shipping [†]
FDMC0310AS	FDMC0310AS	WDFN8 3.3x3.3, 0.65P MLP (SAWN) (Pb-Free)	13"	12 mm	3000 / Tape & Reel
FDMC0310AS-F127	FDMC0310AS	WDFN8 3.3x3.3, 0.65P MLP (PUNCH) (Pb-Free)	13"	12 mm	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

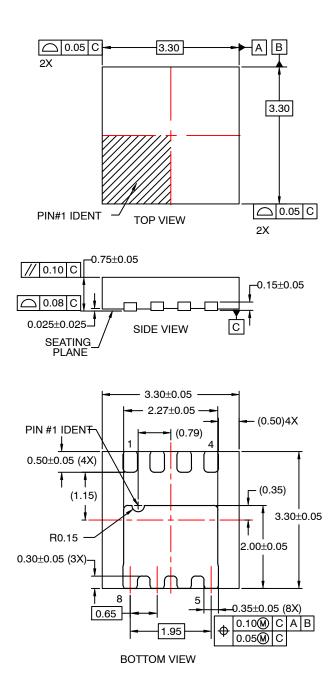
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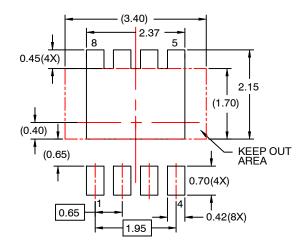
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DATE 31 JUL 2016





RECOMMENDED LAND PATTERN

NOTES:

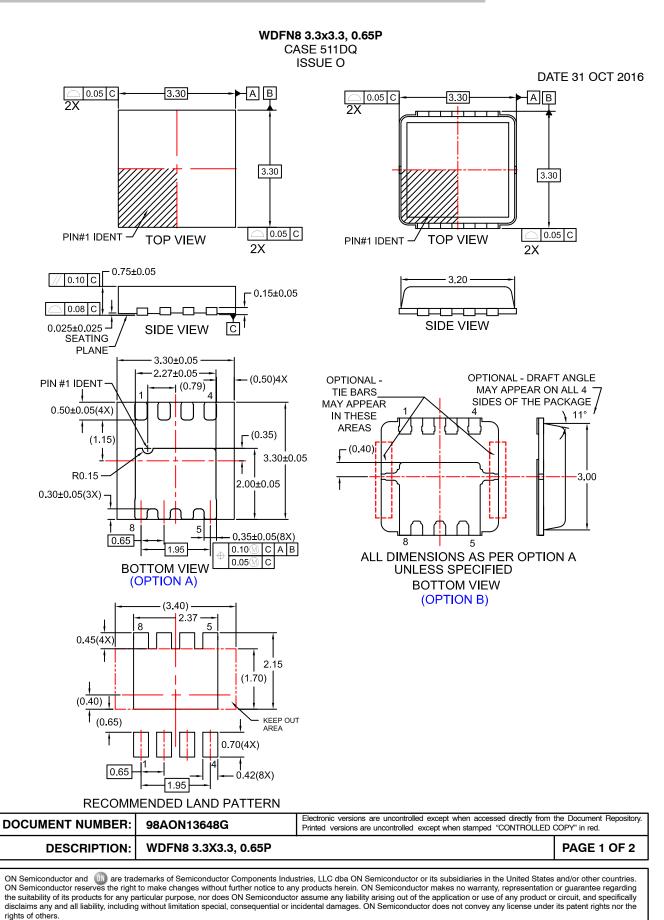
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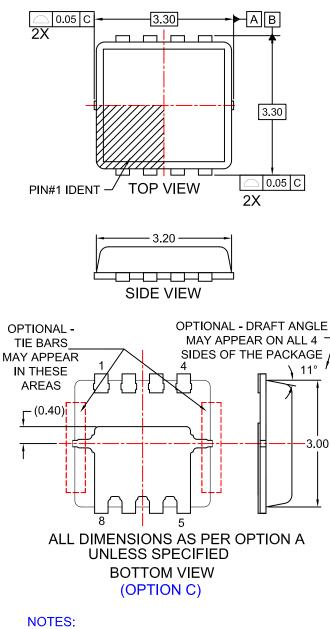
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